

\*RETURN TO FMF - LOCATION 7540 *Pre-Edit*

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09/924,333</u>	Prepared by <u>B.M.G.</u>	Tracking Number	
Examiner-GAU <u>Lund-1763</u>	Date <u>10-3-04</u>	Week Date	
	No. of queries <u>1</u>		

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	q. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

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Sheet 1 of 1

FORM PTO-1449  
(REV. 7-97)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
500176.03APPLICATION NO.  
Not yet assignedINFORMATION DISCLOSURE STATEMENT  
(Use several sheets if necessary)APPLICANT(S)  
Paul D. ShirleyFILING DATE  
Concurrently herewithGROUP ART UNIT 1763  
Not yet assigned10072 U.S. PTO  
09/28/03

06/07/01

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
182	AA	3,710,251	1/9/73	Hagge et al.	324	158 F	
	AB	4,432,635	2/21/84	Mayer	355	30	
	AC	4,544,446	10/1/85	Cady	156	639	
	AD	4,899,686	2/13/90	Toshima et al.	118	50	
	AE	5,034,688	7/23/91	Moulene et al.	324	158 F	
	AF	5,474,877	12/12/95	Suzuki	430	325	
	AG	5,567,267	10/22/96	Kazama et al.	156	345	
	AH	5,578,127	11/26/96	Kimura	118	695	
	AI	5,578,532	11/26/96	van de Ven et al.	437	245	
	AJ	5,580,607	12/3/96	Takekuma et al.	427	240	
	AK	6,073,681	6/13/00	Getchel et al.	165	80.1	
✓	AL	6,168,660 B1	1/2/01	Hayes et al.	118	52	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
182	AM	363140549 A	6/13/88	Japan				X
182	AN	404099018 A	3/31/92	Japan				X
	AO							

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	
	AR	

EXAMINER

DATE CONSIDERED

\* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

Form P7-27V 1/1/94

\\Server05\\Files2\\P\\Documents\\Clients\\Micron Technology\\100\\500176.03\\500176.03 pto-1449 with appl.doc

FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
500176.03APPLICATION NO.  
Not yet assigned

## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)  
Paul D. ShirleyFILING DATE  
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Not yet assigned1c072 U.S. PTO  
09/24/33

08/07/01

## U.S. PATENT DOCUMENTS

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<i>TS</i>	AA	3,710,251	1/9/73	Hagge et al.	324	158 F	
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